

Product Summary

V_{RRM}	1200 V
$I_F (T_c=160^\circ\text{C})$	16 A**
Q_c	96 nC**

Features

- Extremely low reverse current
- No reverse recovery current
- Temperature independent switching
- Positive temperature coefficient on V_F
- Excellent surge current capability
- Low capacitive charge

Benefits

- Essentially no switching losses
- System efficiency improvement over Si diodes
- Increased power density
- Enabling higher switching frequency
- Reduction of heat sink requirements
- System cost savings due to smaller magnetics
- Reduced EMI

Applications

- Switch mode power supplies (SMPS)
- Uninterruptible power supplies
- Motor drivers
- Power factor correction

Package Pin Definitions

- Pin1 - Anode
- Pin2 and backside - Cathode
- Pin3 - Anode

Package Parameters

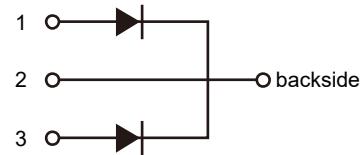
Part Number	Marking	Package
B2D16120HC1	B2D16120HC1	TO-247-3

* Per Leg, ** Per Device

Package: TO-247-3



Electrical Connection



Maximum Ratings ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test conditions	Value	Unit
V_{RRM}	Repetitive peak reverse voltage		1200	V
V_{RSM}	Non-repetitive peak reverse voltage		1200	V
I_F	Continuous forward current	$T_c=25^\circ\text{C}$ $T_c=160^\circ\text{C}$	33*/66** 8*/16**	A
I_{FSM}	Non-repetitive forward surge current	$T_c=25^\circ\text{C}$, $t_p=10\text{ms}$ Half sine wave	80*	A
$\int i^2 dt$	i ² t value	$T_c=25^\circ\text{C}$, $t_p=10\text{ms}$	32*	A ² S
P_{tot}	Power dissipation	$T_c=25^\circ\text{C}$ $T_c=110^\circ\text{C}$	170* 74*	W
T_j	Operating junction temperature		-55~175	°C
T_{stg}	Storage temperature		-55~175	°C
	TO-247 mounting torque	M3 Screw	0.7	Nm

* Per Leg, ** Per Device

Thermal Characteristics

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$R_{th(jc)}$	Thermal resistance from junction to case		0.88*/ 0.44**		K/W

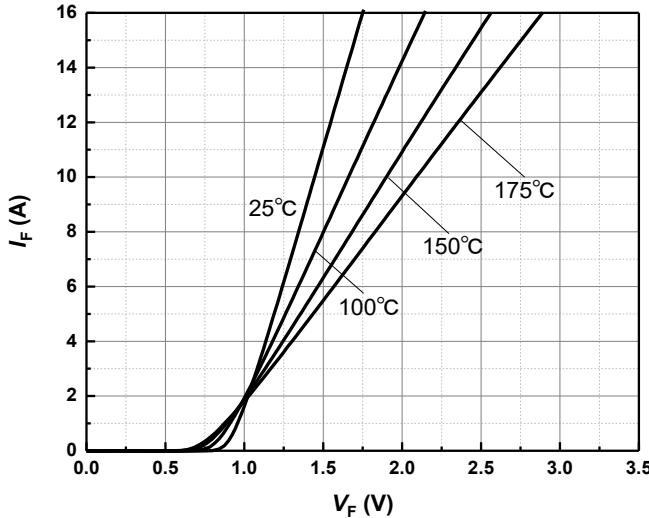
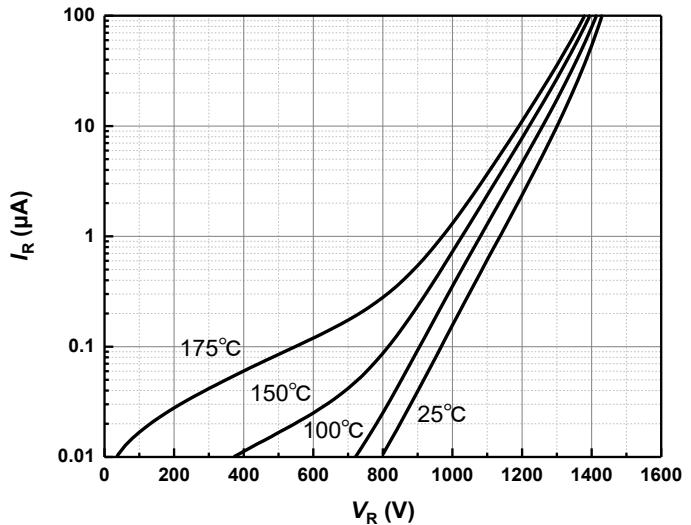
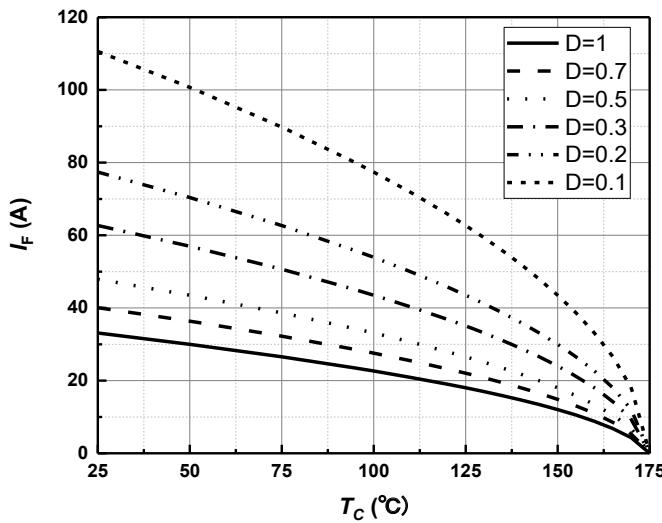
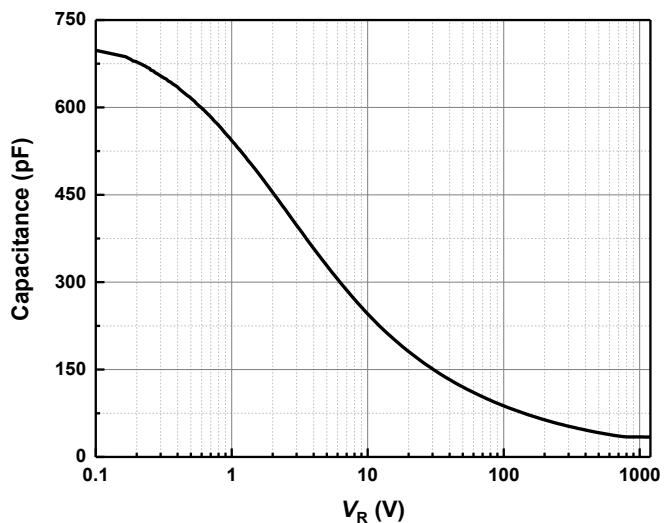
* Per Leg, ** Per Device

Electrical Characteristics (Per Leg)
Static Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
V_{DC}	DC blocking voltage	$T_j=25^\circ C$	1200			V
V_F	Diode forward voltage	$I_F=8A T_j=25^\circ C$ $I_F=8A T_j=175^\circ C$		1.34 1.82	1.6 2.7	V
I_R	Reverse current	$V_R=1200V T_j=25^\circ C$ $V_R=1200V T_j=175^\circ C$		10 30	100 300	μA

AC Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
Q_C	Total capacitive charge	$V_R=800V T_j=25^\circ C$ $Q_C=\int_0^{V_R} C(V)dV$		48		nC
C	Total capacitance	$V_R=1V f=1MHz$ $V_R=400V f=1MHz$ $V_R=800V f=1MHz$		542 46 35		pF
E_C	Capacitance stored energy	$V_R=800V$		25		μJ

Typical Performance (Per Leg)

Figure 1 Typical forward characteristics

Figure 2 Typical reverse current as function of reverse voltage

Figure 3 Diode forward current as function of temperature, D=duty cycle

Figure 4 Typical capacitance as function of reverse voltage, $C=f(V_R)$; $T_j=25^\circ\text{C}$; $f=1 \text{ MHz}$

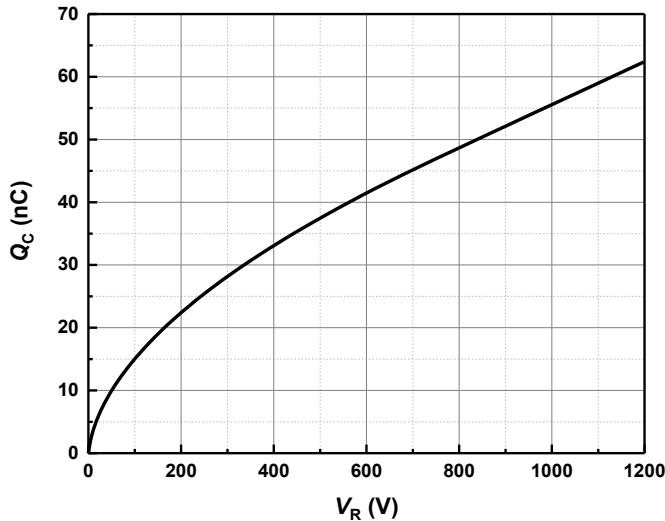
Typical Performance


Figure 5 **Typical reverse charge as function of reverse voltage**

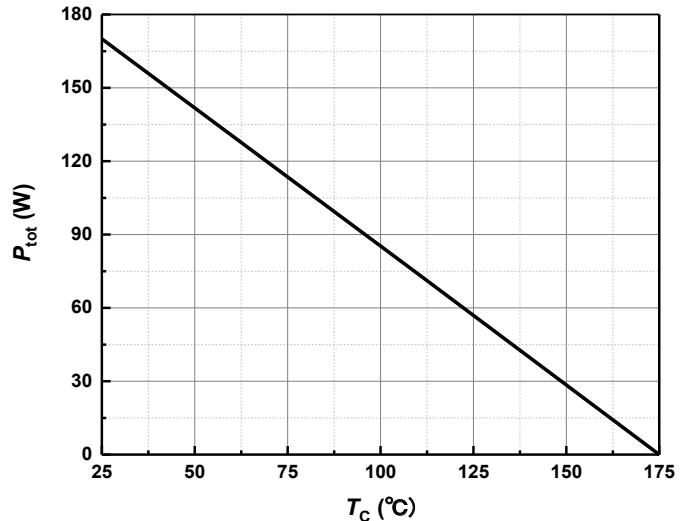


Figure 6 **Power dissipation as function of case temperature**

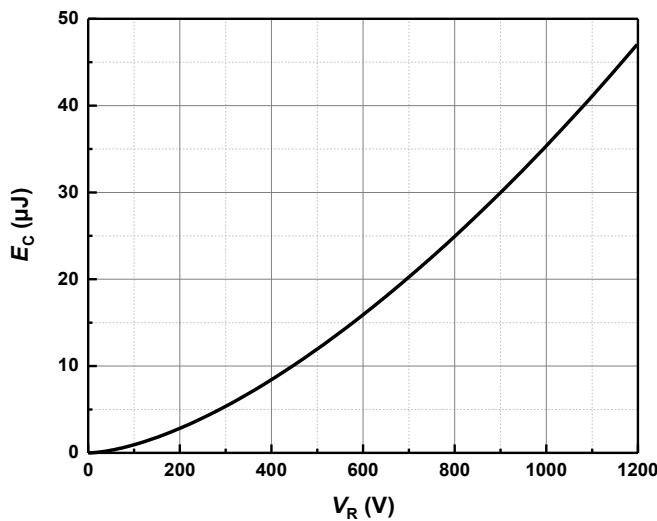


Figure 7 **Capacitance stored energy**

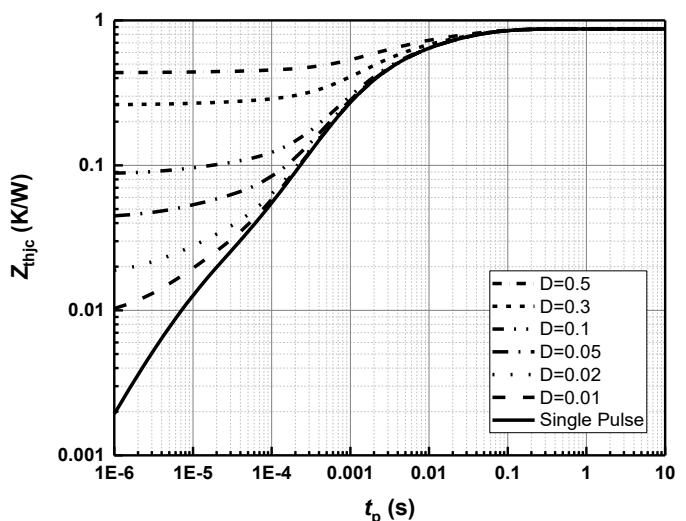
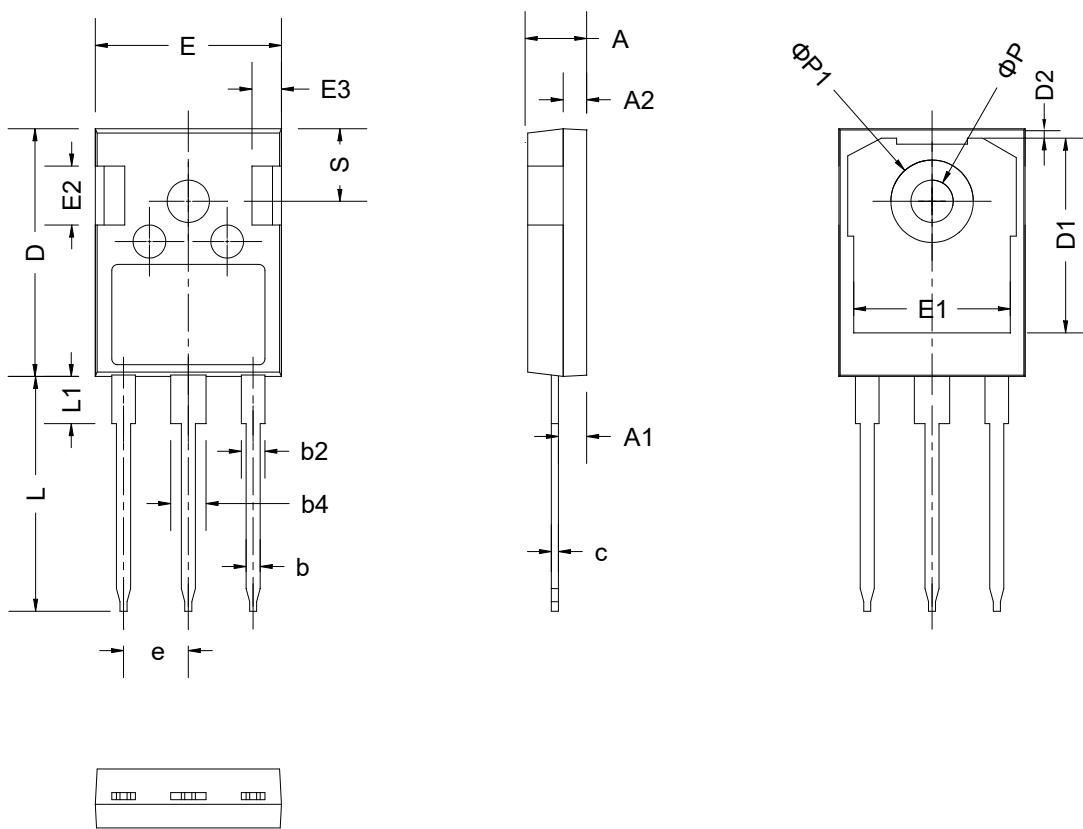


Figure 8 **Max. transient thermal impedance, $Z_{thjc} = f(t)$, parameter: $D = t / T$**



Package Dimensions



SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	-	1.36
b2	1.91	2.01	2.21
b4	2.91	-	3.41
c	0.51	-	0.75
D	20.80	21.00	21.30
D1	16.25	16.55	16.85
D2	1.05	1.17	1.35
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.40	-	5.20
E3	1.50	-	2.70
e	5.436BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
φ P	3.40	3.60	3.80
φ P1	-	-	7.40
S	6.00	6.15	6.30

Revision History

Document Version	Date of Release	Description of Changes
Rev 0.0	2022-05-27	Release of the datasheet.

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